# Coherent Diffraction Imaging (lensless imaging)

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## Introduction of CDI

## CDI methods and applications

- plane wave
- scanning
- Bragg
- Fresnel
- Summary



1- A scanning electron microscope image of the specimen



3- An optical microscope image of the specimen.



2- Diffraction pattern of the specimen (using a logarithmic intensity scale)



4- The specimen image as reconstructed from the diffraction pattern of Fig. 2.

### **Coherent diffraction imaging**





### Phase retrieval of simulated image





- Radiation damage of sample (ultrafast process 10s fs)
- Radiation damage of detector
- Poor signal-to-noise ratio

- Use of ultrashort pulses
- Beam stop / beam dump
- Brighter beam / multiple shots

SLAO

### **CDI methods**





## Plane-wave CDI



- Insensitive to sample vibration
- Easy to get 3-D datasets and reconstruction
- Can be implemented in single-shot experiments

## Plane-wave CDI Imaging single mimivirus particles





- LCLS, 30 Hz, 1.8 keV,
  <70 fs pulse,</li>
  8 × 10<sup>11</sup> photons/pulse
- 32 nm resolution



## **Scanning CDI**



- Applied to extended objects
- Utilizes curved wave front
- Fast convergence of the phase retrieval algorithm

## **Scanning CDI** Imaging of a sample



- Swiss Light source
  8 keV x-ray
- Gold plate and balls
- 50 nm resolution



## **Bragg CDI**

-SLAC



- Applied to nanocrystals
- Able to determine the 3D strain tensor and ion displacement

## **Bragg CDI** 3-D Imaging of Strain Inside ZnO Nanocrystals SLAC



Advanced Photon Source
 9 keV x-ray

40 nm resolution

#### Ion displacement pattern



## **Fresnel CDI**



- Rapid convergence due to curvature
- the ability to image a subregion in an extended sample with a single view
- Higher resolution

## **Fresnel CDI** Imaging nonperiodic Au sample



- APS 1.8 keV x-ray
- 24 nm resolution



## Summary

-SLAC

- CDI is a novel form of lensless X-ray imaging
- Ideally suited for non-periodic objects or nanocystals
- Resolution limited by radiation damage to sample
- Need shorter, brighter pulses

- Best experimentally-achieved resolutions with CDI:
  - ~2 nm for inorganic materials
  - ~10-20 nm for organic materials

#### References

![](_page_17_Picture_1.jpeg)

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![](_page_18_Picture_0.jpeg)

## **THANKS FOR YOUR ATTENTION !**